

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/757,405	TAKINOSAWA ET AL.
	<b>Examiner</b> David E. Martinez	<b>Art Unit</b> 2181

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East see attached	11/17/2006	DM
eDan inventor search	11/17/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent, IBM_TDB.	11/17/2006	DM
710/2,22- 28,62,72,100,300,301,305,313".ccls.. with keywords and text search	11/17/2006	DM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
710	62,72,301	11/17/2006	DM
Databases: US Patents, US PGPUBS, USOCR, EPO, JPO, Derwent,		11/17/2006	DM